

AOT8N65/AOTF8N65

650V, 8A N-Channel MOSFET

General Description

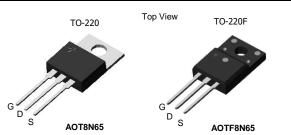
The AOT8N65 & AOTF8N65 have been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{\text{DS(on)}},\,C_{\text{iss}}$ and C_{rss} along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

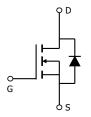
Product Summary

 $\begin{array}{lll} V_{DS} & 750V@150{^\circ\!\!\!C} \\ I_D \ (at \ V_{GS} \! = \! 10V) & 8A \\ R_{DS(ON)} \ (at \ V_{GS} \! = \! 10V) & < 1.15\Omega \end{array}$

100% UIS Tested 100% R_g Tested







| Absolute Maximum Ratings T _A =25°C unless otherwise noted | | | | | | | | | | |
|--|-----------------------|-------------------|------------|----------|-------|--|--|--|--|--|
| Parameter | | Symbol | AOT8N65 | AOTF8N65 | Units | | | | | |
| Drain-Source Voltage | | V _{DS} | 650 | | V | | | | | |
| Gate-Source Voltage | | V_{GS} | ±30 | | V | | | | | |
| Continuous Drain | T _C =25°C | —I _D | 8 | 8* | | | | | | |
| Current | T _C =100°C | | 5.2 | 5.2* | Α | | | | | |
| Pulsed Drain Current C | | I _{DM} | 32 | | | | | | | |
| Avalanche Current ^C | | I _{AR} | 3.4 | | А | | | | | |
| Repetitive avalanche energy ^C | | E _{AR} | 173 | | mJ | | | | | |
| Single plused avalanche energy ^G | | E _{AS} | 347 | | mJ | | | | | |
| MOSFET dv/dt ruggedness | | -dv/dt | 50 | | V/ns | | | | | |
| Peak diode recovery dv/dt | | | 5 | | V/110 | | | | | |
| Power Dissipation ^B | T _C =25°C | —P _D | 208 | 50.0 | W | | | | | |
| | Derate above 25°C | | 1.67 | 0.3 | W/ °C | | | | | |
| Junction and Storage Temperature Range | | T_J , T_{STG} | -55 to 150 | | °C | | | | | |
| Maximum lead temperature for soldering | | | | | | | | | | |
| purpose, 1/8" from case for 5 seconds | | T_L | 300 | | °C | | | | | |
| Thermal Characterist | tics | | | | | | | | | |
| Parameter | | Symbol | AOT8N65 | AOTF8N65 | Units | | | | | |
| Maximum Junction-to-Ambient A,D | | $R_{\theta JA}$ | 65 | 65 | °C/W | | | | | |
| Maximum Case-to-sink ^A | | $R_{\theta CS}$ | 0.5 | | °C/W | | | | | |
| Maximum Junction-to-Case | | $R_{\theta JC}$ | 0.6 | 2.5 | °C/W | | | | | |

^{*} Drain current limited by maximum junction temperature.



Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Тур | Max | Units | | | |
|----------------------|---------------------------------------|---|------|------|------|-------|--|--|--|
| STATIC PARAMETERS | | | | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V, T _J =25°C | 650 | | | | | | |
| | | I _D =250μA, V _{GS} =0V, T _J =150°C | | 750 | | V | | | |
| BV _{DSS} | Zero Gate Voltage Drain Current | | | | | V/°C | | | |
| /∆TJ | | ID=250μA, VGS=0V | | 0.7 | | V, 0 | | | |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =650V, V _{GS} =0V | | | 1 | μА | | | |
| 555 | Ţ | V _{DS} =520V, T _J =125°C | | | 10 | F | | | |
| I_{GSS} | Gate-Body leakage current | V_{DS} =0V, V_{GS} =±30V | | | ±100 | nA | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=5V I_{D}=250\mu A$ | 3 | 4 | 4.5 | V | | | |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V_{GS} =10V, I_D =4A | | 0.91 | 1.15 | Ω | | | |
| g _{FS} | Forward Transconductance | V_{DS} =40V, I_{D} =4A | | 11 | | S | | | |
| V_{SD} | Diode Forward Voltage | I _S =1A,V _{GS} =0V | | 0.74 | 1 | V | | | |
| Is | Maximum Body-Diode Continuous Current | | | | 8 | Α | | | |
| I _{SM} | Maximum Body-Diode Pulsed Current | | | | 32 | Α | | | |
| DYNAMIC | PARAMETERS | | | | | | | | |
| C _{iss} | Input Capacitance | | 930 | 1165 | 1400 | pF | | | |
| Coss | Output Capacitance | V_{GS} =0V, V_{DS} =25V, f=1MHz | 80 | 101 | 120 | pF | | | |
| C _{rss} | Reverse Transfer Capacitance | | 7 | 9 | 11 | pF | | | |
| R_g | Gate resistance | V_{GS} =0V, V_{DS} =0V, f=1MHz | 1.8 | 3.7 | 5.6 | Ω | | | |
| SWITCHING PARAMETERS | | | | | | | | | |
| Q_g | Total Gate Charge | | 18.5 | 23.5 | 28 | nC | | | |
| Q_{gs} | Gate Source Charge | V_{GS} =10V, V_{DS} =520V, I_{D} =8A | 5 | 6.2 | 7.5 | nC | | | |
| Q_{gd} | Gate Drain Charge | | 7.5 | 9.5 | 11.5 | nC | | | |
| t _{D(on)} | Turn-On DelayTime | | | 26 | | ns | | | |
| t _r | Turn-On Rise Time | V_{GS} =10V, V_{DS} =325V, I_{D} =8A, | | 51 | | ns | | | |
| t _{D(off)} | Turn-Off DelayTime | $R_G=25\Omega$ | | 65 | | ns | | | |
| t _f | Turn-Off Fall Time | | | 43 | | ns | | | |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =8A,dI/dt=100A/μs,V _{DS} =100V | 235 | 295 | 355 | ns | | | |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =8A,dI/dt=100A/μs,V _{DS} =100V | 4 | 5 | 6 | μC | | | |

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A. The value of R _{BJA} is measured with the device in a still air environment with T _A =25° C.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

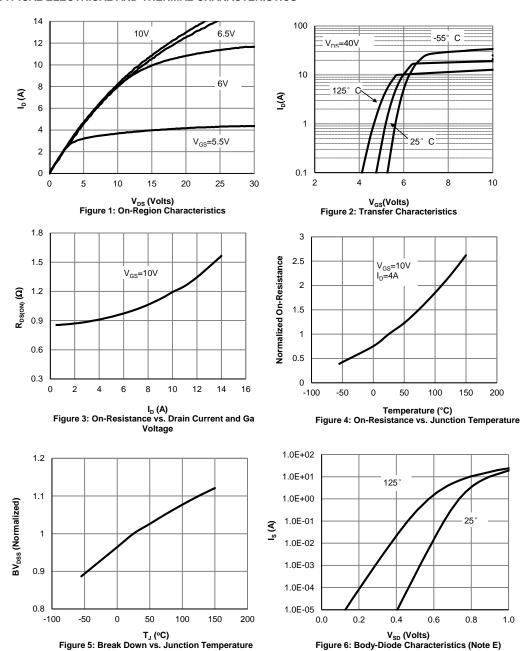
C. Renetitive rating pulse width limited by it realize the property of th

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C, Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^{\circ}$ C. The SOA curve provides a single pulse rating. G. L=60mH, $I_{AS}=3.3A$, $V_{DD}=150V$, $R_{C}=25\Omega$, Starting $T_{J}=25^{\circ}$ C



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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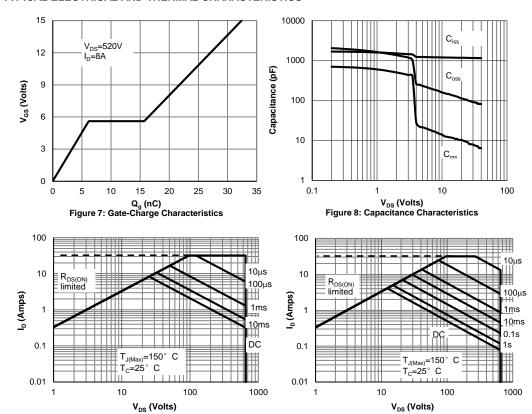


Figure 9: Maximum Forward Biased Safe Operating Area for AOT8N65 (Note F)

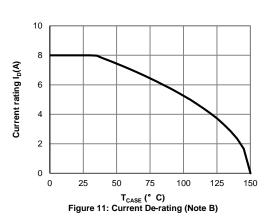
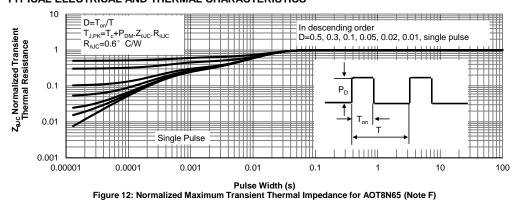
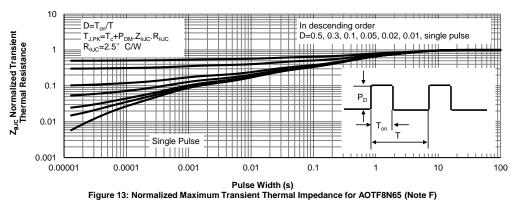


Figure 10: Maximum Forward Biased Safe Operating Area for AOTF8N65 (Note F)



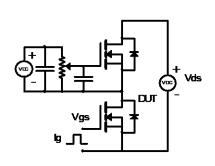
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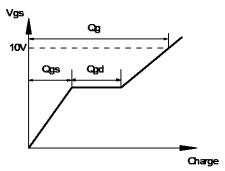




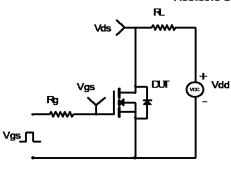


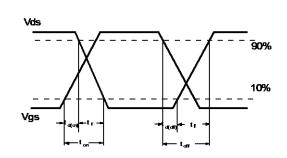
Gate Charge Test Circuit & Waveform



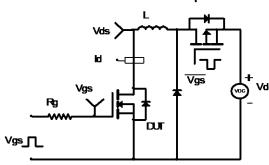


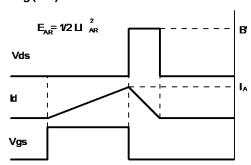
Resistive Switching Test Circuit & Waveforms



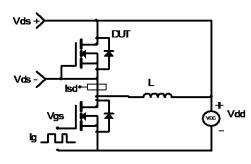


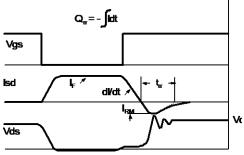
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms





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